#### 

- Function, Pinout, and Drive Compatible With FCT and F Logic
- Reduced V<sub>OH</sub> (Typically = 3.3 V) Versions of Equivalent FCT Functions
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- ESD Protection Exceeds JESD 22
  2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)
- Matched Rise and Fall Times
- Fully Compatible With TTL Input and Output Logic Levels
- CY54FCT163T
  - 32-mA Output Sink Current
  - 12-mA Output Source Current
- CY74FCT163T
  - 64-mA Output Sink Current
  - 32-mA Output Source Current

#### description

The 'FCT163T devices are high-speed synchronous modulo-16 binary counters. They are synchronously presettable for application in programmable dividers. These devices have two

types of count-enable (CEP and CET) inputs, plus a terminal-count (TC) output for versatility in forming synchronous multistaged counters. The 'FCT163T devices have a synchronous-reset (SR) input that overrides counting and parallel loading, and allows the outputs to be reset simultaneously on the rising edge of the clock.

These devices are fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

	PIN DESCRIPTION
NAME	DESCRIPTION
CEP	Count-enable parallel input
CET	Count-enable trickle input
CP	Clock pulse input (active rising edge)
SR	Synchronous-reset input (active low)
Р	Parallel data inputs
PE	Parallel-enable input (active low)
Q	Flip-flop outputs
TC	Terminal-count output

DIN DESCRIPTION





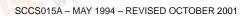
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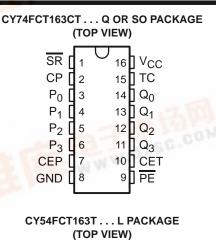
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

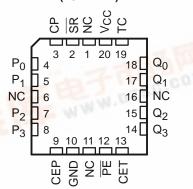
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



Copyright © 2001, Texas Instruments Incorporated On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.







NC - No internal connection

### SCCS SAT MAY 7904 CREVISED OCTORERS 001

OKDERING INI OKMATION										
TA	PACI	KAGE <sup>†</sup>	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING					
	QSOP – Q	Tape and reel	5.8	CY74FCT163CTQCT	FT163-3					
–40°C to 85°C	SOIC – SO	Tube	5.8	CY74FCT163CTSOC	FCT163C					
	3010 - 30	Tape and reel	5.8	CY74FCT163CTSOCT	FCT103C					
–55°C to 125°C	LCC – L	Tube	11.5	CY54FCT163TLMB						

**ORDERING INFORMATION** 

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

_	FUNCTION TABLE									
	INP	UTS		ACTION ON THE RISING						
SR	PE	CET	CEP	CLOCK EDGE(S)						
L	Х	Х	Х	Reset (clear)						
н	L	Х	Х	$\text{Load}\;(P_n\toQ_n)$						
н	Н	Н	Н	Count (incremental)						
н	Н	L	Х	No change (hold)						
Н	Н	Х	L	No change (hold)						

### FUNCTION TABLE

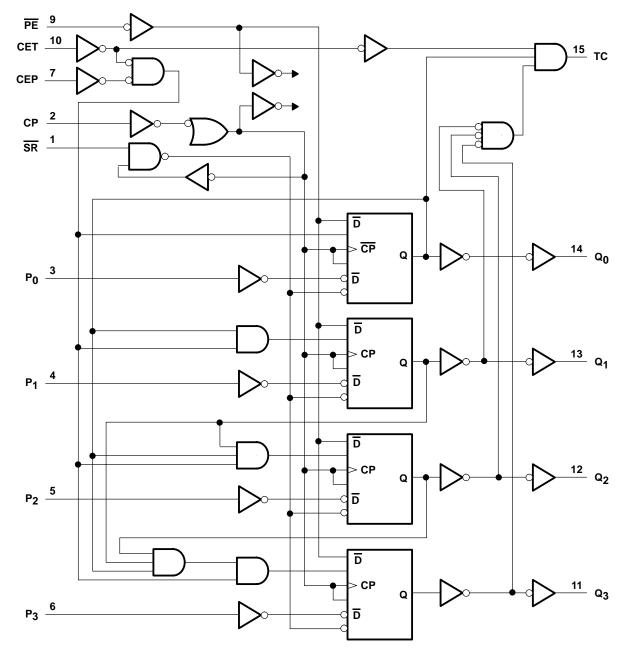
H = High logic level, L = Low logic level, X = Don't care



<u>查询"CY74FCT163T"供应商</u>

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## logic diagram (positive logic)





#### SCC SE SAT MAY 7904 CREVISED OCTORERS 001

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range to ground potential	
DC input voltage range	. –0.5 V to 7 V
DC output voltage range	0.5 V to 7 V
DC output current (maximum sink current/pin)	120 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 1): Q package	90°C/W
SO package	57°C/W
Ambient temperature range with power applied, T <sub>A</sub>	–65°C to 135°C
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>+</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

### recommended operating conditions (see Note 2)

		CY54FCT163T		3T	CY7	3T	UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
ЮН	High-level output current			-12			-32	mA
IOL	Low-level output current			32			64	mA
Τ <sub>Α</sub>	Operating free-air temperature	-55		125	-40		85	°C

NOTE 2: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation.



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electrical characteristics	over	recommended	operating	free-air	temperature	range	(unless
otherwise noted)					-	•	•

DADAMETED		CY	′54FCT16	63T	CY	74FCT16	3T			
PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	MIN	түр†	MAX	UNIT		
V	$V_{CC} = 4.5 \text{ V}, \qquad I_{IN} = -18 \text{ mA}$		-0.7	-1.2				v		
VIK	$V_{CC} = 4.75 \text{ V}, \qquad I_{IN} = -18 \text{ mA}$					-0.7	-1.2	v		
Vон	$V_{CC} = 4.5 \text{ V}, \qquad I_{OH} = -12 \text{ mA}$	2.4	3.3							
VOH	$V_{CC} = 4.75 V$ $I_{OH} = -32 mA$				2			V		
	$I_{OH} = -15 \text{ mA}$				2.4	3.3				
Ve	$V_{CC} = 4.5 \text{ V}, \qquad I_{OL} = 32 \text{ mA}$		0.3	0.55				v		
VOL	$V_{CC} = 4.75 \text{ V},  I_{OL} = 64 \text{ mA}$					0.3	0.55	v		
V <sub>hys</sub>	All inputs		0.2			0.2		V		
1.	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = V_{CC}$			5				μA		
l	$V_{CC} = 5.25 \text{ V},  V_{IN} = V_{CC}$						5	μΑ		
ίн	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = 2.7 \text{ V}$			±1				μA		
ЧН	$V_{CC} = 5.25 \text{ V}, \qquad V_{IN} = 2.7 \text{ V}$						±1	μΛ		
1	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = 0.5 \text{ V}$			±1				μΑ		
١Ľ	$V_{CC} = 5.25 \text{ V}, \qquad V_{IN} = 0.5 \text{ V}$						±1	μΛ		
le et	V <sub>CC</sub> = 5.5 V, V <sub>OUT</sub> = 0 V	-60	-120	-225				mA		
IOS‡	V <sub>CC</sub> = 5.25 V, V <sub>OUT</sub> = 0 V				-60	-120	-225			
loff	V <sub>CC</sub> = 0 V, V <sub>OUT</sub> = 4.5 V			±1			±1	μΑ		
las	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} \le 0.2 \text{ V}, \qquad V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.1	0.2				mA		
ICC	$V_{CC} = 5.25 \text{ V},  V_{IN} \le 0.2 \text{ V},  V_{IN} \ge V_{CC} - 0.2 \text{ V}$					0.1	0.2	mA		
	$V_{CC} = 5.5 \text{ V}, V_{IN} = 3.4 \text{ V}^{\$}, f_1 = 0$ , Outputs open		0.2	2				mA		
∆ICC	$V_{CC} = 5.25 \text{ V}, V_{IN} = 3.4 \text{ V}\$, f_1 = 0$ , Outputs open					0.2	2	mA		
۹	$\label{eq:VCC} \begin{array}{l} V_{CC} = 5.5 \ \text{V}, \ \text{Load mode}, \ \text{Outputs open}, \\ \text{One bit switching at 50\% duty cycle}, \\ \text{CEP} = \text{CET} = \overrightarrow{\text{PE}} = \text{GND}, \ \overrightarrow{\text{SR}} = \text{V}_{CC}, \\ \text{V}_{IN} \leq 0.2 \ \text{V or } \ \text{V}_{IN} \geq \text{V}_{CC} - 0.2 \ \text{V} \end{array}$		0.06	0.12				mA/		
ICCD	$\label{eq:VC} \begin{array}{l} V_{CC} = 5.25 \ \text{V}, \ \text{Load mode, Outputs open,} \\ \text{One bit switching at 50\% duty cycle,} \\ \text{CEP} = \text{CET} = \overrightarrow{\text{PE}} = \text{GND, SR} = \text{V}_{CC}, \\ \text{V}_{IN} \leq 0.2 \ \text{V or } \ \text{V}_{IN} \geq \text{V}_{CC} - 0.2 \ \text{V} \end{array}$					0.06	0.12	MHz		

<sup>†</sup> Typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> =  $25^{\circ}$ C.

\* Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, IOS tests should be performed last.

§ Per TTL-driven input (V<sub>IN</sub> = 3.4 V); all other inputs at V<sub>CC</sub> or GND

 $\P$  This parameter is derived for use in total power-supply calculations.



#### SCC Star SAT MAY 7994 CREV ISET OCTORE REPORT

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER		TEST CONDITION		CY	54FCT16	3Т	CY	74FCT16	3T	
PARAMETER	TEST CONDITIONS			MIN	TYP†	MAX	MIN	түр†	MAX	UNIT
	V <sub>CC</sub> = 5.5 V, Load mode,	One bit switching at f <sub>1</sub> = 5 MHz at	$V_{IN} \leq 0.2 \text{ V or} \\ V_{IN} \geq V_{CC} - 0.2 \text{ V}$		0.7	1.4				
	f <sub>0</sub> = 10 MHz,	50% duty cycle	$V_{IN}$ = 3.4 V or GND		1.2	3.4				
. #	Outputs open, $\underline{CEP} = CET =$ $\overline{PE} = GND,$	Four bits switching at	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array} \end{array} \label{eq:VIN}$		1.6	3.2				
	SR = V <sub>CC</sub>	f <sub>1</sub> = 5 MHz at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		2.9	8.2				~ ^
IC#	$f_0 = 10 \text{ MHz},$ $f_0 = 10 \text{ MHz},$ Load mode, Outputs open, CEP = CET = Sw	One bit switching at f <sub>1</sub> = 5 MHz at	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array} \end{array} \label{eq:VIN}$					0.7	1.4	mA
		50% duty cycle	$V_{IN}$ = 3.4 V or GND					1.2	3.4	
		$\frac{CEP}{DE} = CET = switching at$	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array} \end{array} \label{eq:VIN}$					1.6	3.2	
	$\overline{SR} = V_{CC}$	f <sub>1</sub> = 5 MHz at 50% duty cycle	$V_{IN}$ = 3.4 V or GND					2.9	8.2	
Ci					5	10		5	10	pF
Co					9	12		9	12	pF

<sup>†</sup> Typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

 ${}^{\#}I_{C} = I_{CC} + \Delta I_{CC} \times D_{H} \times N_{T} + I_{CCD} (f_{0}/2 + f_{1} \times N_{1})$ 

Where:

I<sub>C</sub> = Total supply current I<sub>CC</sub> = Power-supply current with CMOS input levels

 $\Delta I_{CC}$  = Power-supply current for a TTL high input (VIN = 3.4 V)

 $D_H$  = Duty cycle for TTL inputs high

NT = Number of TTL inputs at DH

I<sub>CCD</sub> = Dynamic current caused by an input transition pair (HLH or LHL)

= Clock frequency for registered devices, otherwise zero fo

= Input signal frequency f1

N<sub>1</sub> = Number of inputs changing at f1

All currents are in milliamperes and all frequencies are in megahertz.

I Values for these conditions are examples of the I<sub>CC</sub> formula.

#### timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			CY54FC	T163T	CY74FC1	Г163CT	UNIT
			MIN	MAX	MIN	MAX	UNIT
	Dulas duration high or law	Clock (load)	5		4		
۲W	t <sub>w</sub> Pulse duration, high or low	Clock (count)	8		5		ns
		P before CP↑	5.5		3.5		
t <sub>su</sub>	Setup time, high or low	PE or SR before CP↑	13.5		7.6		ns
		CEP or CET before CP↑	13		7.6		
		P after CP↑	2		1.5		
t <sub>h</sub>	Hold time, high or low	PE or SR after CP↑	1.5		1		ns
		CEP or CET after CP↑	0		0		



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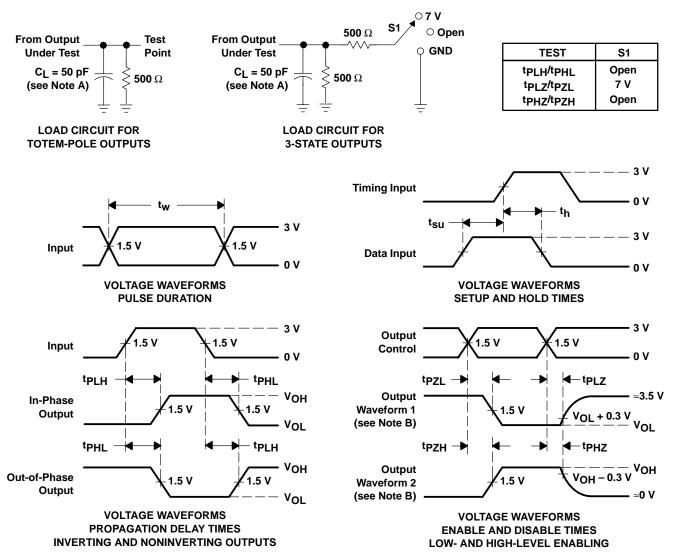
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### switching characteristics over operating free-air temperature range (see Figure 1)

	PARAMETER	FROM	то	CY54FC	T163T	CY74FC1	Г163CT	UNIT
	FARAINETER	(INPUT)	(INPUT) (OUTPUT)			MIN	MAX	UNIT
<sup>t</sup> PLH	Propagation delay	СР	Q	2	11.5	1.5	5.8	ns
<sup>t</sup> PHL	(PE high)	CF	CP Q		11.5	1.5	5.8	115
<sup>t</sup> PLH	Propagation delay	ion delay CP TC		2	10	1.5	5.2	ns
<sup>t</sup> PHL	(PE low)	CF		2	10	1.5	5.2	115
<sup>t</sup> PLH		СР	тс	2	16.5	1.5	7.8	
<sup>t</sup> PHL		CF		2	16.5	1.5	7.8	ns
<sup>t</sup> PLH		CET	TC	1.5	9	1.5	4.4	200
<sup>t</sup> PHL		UCT UCT		1.5	9	1.5	4.4	ns



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### PARAMETER MEASUREMENT INFORMATION

NOTES: A. C<sub>1</sub> includes probe and jig capacitance.

 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. The outputs are measured one at a time with one input transition per measurement.

#### Figure 1. Load Circuit and Voltage Waveforms



21-May-2007

### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
CY54FCT163TLMB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
CY74FCT163CTQCT	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT163CTQCTE4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT163CTQCTG4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT163CTSOC	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT163CTSOCE4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT163CTSOCG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT163CTSOCT	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT163CTSOCTE4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT163CTSOCTG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

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Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

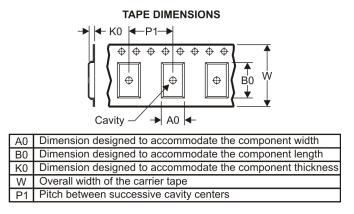
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### TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

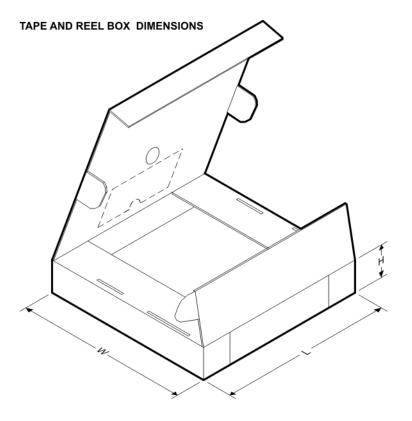


Device		Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT163CTSOCT	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1



# PACKAGE MATERIALS INFORMATION

11-Mar-2008



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT163CTSOCT	SOIC	DW	16	2000	346.0	346.0	33.0

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